

#### 150 mA Ultra-Low Quiescent Current, Capacitorless LDO Regulator

#### Features

- Low Quiescent Current: 600 nA
- Input Voltage Range: 1.4V to 6.0V
- Standard Output Voltages: 1.2V, 1.8V, 1.9V, 2.0V, 2.2V, 2.5V, 3.0V, 3.3V, 5.0V
- Output Accuracy:  $\pm 20$  mV for 1.2V and 1.8V Options and  $\pm 1\%$  for V<sub>R</sub>  $\geq 2.0V$
- Temperature Stability: ±50 ppm/°C
- Maximum Output Current: 150 mA
- Low ON Resistance:  $3.3\Omega \otimes V_R = 3.0V$
- Standby Current: 10 nA
- Protection Circuits: Current Limiter, Short Circuit, Foldback
- SHDN Pin Function: ON/OFF Logic = Enable High
- C<sub>OUT</sub> Discharge Circuit when SHDN Function is Active
- Output Capacitor: Low Equivalent Series Resistance (ESR) Ceramic, Capacitorless Compatible
- Operating Temperature: -40°C to +85°C (Industrial)
- Available Packages:
  - 4-Lead 1 x 1 mm UQFN
  - 5-Lead SOT-23
- Environmentally Friendly: EU RoHS Compliant, Lead-Free

#### Applications

- Energy Harvesting
- · Long-Life, Battery-Powered Applications
- Portable Electronics
- Ultra-Low Consumption "Green" Products
- Mobile Devices/Terminals
- Wireless LAN
- Modules (Wireless, Cameras)

#### **Related Literature**

- AN765, Using Microchip's Micropower LDOs (DS00765), Microchip Technology Inc.
- AN766, Pin-Compatible CMOS Upgrades to Bipolar LDOs (DS00766), Microchip Technology Inc.
- AN792, A Method to Determine How Much Power a SOT23 Can Dissipate in an Application (DS00792), Microchip Technology Inc.

#### **General Description**

The MCP1711 is a highly accurate CMOS low dropout (LDO) voltage regulator that can deliver up to 150 mA of current while consuming only 0.6  $\mu$ A of quiescent current (typical). The input operating range is specified from 1.4V to 6.0V, making it an ideal choice for mobile applications and one-cell Li-Ion powered applications.

The MCP1711 is capable of delivering 150 mA output current with only 0.32V (typical) for V<sub>R</sub> = 5.0V, and 1.41V (typical) for V<sub>R</sub> = 1.2V of input-to-output voltages differential. The output voltage accuracy of the MCP1711 is typically  $\pm$  0.02V for V<sub>R</sub> < 2.0V and  $\pm$ 1% for V<sub>R</sub>  $\geq$  2.0V at +25°C. The temperature stability is approximately  $\pm$ 50 ppm/°C. Line regulation is  $\pm$ 0.01%/V typical at +25°C.

The output voltages available for the MCP1711 range from 1.2V to 5.0V. The LDO output is stable even if an output capacitor is not connected, due to an excellent internal phase compensation. However, for better transient responses, the output capacitor should be added. The MCP1711 is compatible with low ESR ceramic output capacitors.

Overcurrent limit and short-circuit protection embedded into the device provide a robust solution for any application.

The MCP1711 has a true current foldback feature. When the load decreases beyond the MCP1711 load rating, the output current and output voltage will foldback toward 80 mA (typical) at approximately 0V output. When the load impedance increases and returns to the rated load, the MCP1711 will follow the same foldback curve as the device comes out of current foldback.

If the device is in Shutdown mode, by inputting a low-level signal to the SHDN pin, the current consumption is reduced to less than 0.1  $\mu$ A (typically 0.01  $\mu$ A). In Shutdown mode, if the output capacitor is used, it will be discharged via the internal dedicated switch and, as a result, the output voltage quickly returns to 0V.

The package options for the MCP1711 are the 4-lead  $1 \times 1 \text{ mm}$  UQFN and the 5-lead SOT-23, which make the device ideal for small and compact applications.

#### **Package Types**



#### **Typical Application Circuit**



#### Functional Block Diagram



#### 1.0 ELECTRICAL CHARACTERISTICS

#### Absolute Maximum Ratings †

Input Voltage, V <sub>IN</sub>	+6.5V -0.3V to +6.5V
Output Current, I <sub>OUT</sub> <sup>(1)</sup>	
Output Voltage, V <sub>OUT</sub> <sup>(2)</sup>	
Power Dissipation	
5-Lead SOT-23	. 600 mW (JEDEC 51-7 FR-4 board with thermal vias) or 250 mW <sup>(3)</sup>
4-Lead 1 x 1 mm UQFN	. 550 mW (JEDEC 51-7 FR-4 board with thermal vias) or 100 mW <sup>(3)</sup>
Storage Temperature	
Operating Ambient Temperature	40°C to +85°C
	±1 kV HBM, ±200V MM
<b>† Notice:</b> Stresses above those listed under "Abs	olute Maximum Ratings" may cause permanent damage to the device.
This is a stress rating only and functional operation	on of the device at those or any other conditions above those indicated
in the operational sections of this specification is periods may affect device reliability.	s not intended. Exposure to maximum rating conditions for extended

- **Note 1:** Provided that the device is used in the range of  $I_{OUT} \le P_D/(V_{IN} V_{OUT})$ .
  - 2: The maximum rating corresponds to the lowest value between  $V_{IN}$  + 0.3V or +6.5V.
  - 3: The device is mounted on one layer PCB with minimal copper that does not provide any additional cooling.

#### DC CHARACTERISTICS

**Electrical Characteristics:** Unless otherwise indicated,  $V_{\overline{SHDN}} = V_{IN}$ ,  $I_{OUT} = 1$  mA,  $C_{IN} = C_{OUT} = 0$  µF,  $V_{IN} = 3.5V$  for  $V_R < 2.5V$  and  $V_{IN} = V_R + 1V$  for  $V_R \ge 2.5V$ ,  $T_A = +25^{\circ}C$ 

Parameters	Sym.	Min.	Тур.	Max.	Units	Conditions	
Input-Output Characteristics							
Input Voltage	V <sub>IN</sub>	1.4		6.0	V	I <sub>OUT</sub> = 1 μA	
Output Voltage	V <sub>OUT</sub>	V <sub>R</sub> - 0.02	V <sub>R</sub>	V <sub>R</sub> + 0.02	V	V <sub>R</sub> < 2.0V	
		V <sub>R</sub> x 0.99	V <sub>R</sub>	V <sub>R</sub> x 1.01		$V_R \ge 2.0V$	
Maximum Output Current	I <sub>OUT</sub>	150	-	—	mA		
Load Regulation	$\Delta V_{OUT}$	-16	±3	+16	mV	$1 \ \mu A \leq I_{OUT} \leq 1 \ mA$	
		-50	±17	+50		$1 \text{ mA} \le I_{OUT} \le 150 \text{ mA}$	
Dropout Voltage <sup>(1)</sup>	V <sub>DROPOUT1</sub>	_	V <sub>DI</sub>	ROP1 (2)	V	I <sub>OUT</sub> = 50 mA	
	V <sub>DROPOUT2</sub>	_	V <sub>DI</sub>	ROP2 <sup>(2)</sup>		I <sub>OUT</sub> = 150 mA	
Input Quiescent Current	۱ <sub>q</sub>	_	0.60	1.27	μA	V <sub>R</sub> < 1.9V	
		_	0.65	1.50		$1.9V \le V_R < 4.0V$	
		_	0.80	1.80		$V_R \ge 4.0V$	
Input Quiescent Current for SHDN mode	ISHDN	_	0.01	0.10	μΑ	$V_{IN} = 6.0V$ $V_{\overline{SHDN}} = V_{IN}$	
Line Regulation	ΔV <sub>OUT</sub> / (ΔV <sub>IN</sub> x V <sub>OUT</sub> )	-0.13	±0.01	+0.13	%/V	$\begin{array}{l} I_{OUT} = 1 \ \mu A \\ V_R + 0.5 V \leq V_{IN} \leq 6.0 V \end{array}$	
		-0.19	±0.01	+0.19		$I_{OUT}$ = 1 mA VR $\geq$ 1.2V, V <sub>R</sub> + 0.5V $\leq$ V <sub>IN</sub> $\leq$ 6.0V	

**Note 1:** The dropout voltage is defined as the input to output differential at which the output voltage drops 2% below the output voltage value that was measured with an applied input voltage of  $V_{IN} = V_R + 1V$ .

2: V<sub>DROP1</sub>, V<sub>DROP2</sub>: Dropout Voltage (Refer to the DC Characteristics Voltage Table).

#### **DC CHARACTERISTICS (CONTINUED)**

**Electrical Characteristics:** Unless otherwise indicated,  $V_{\overline{SHDN}} = V_{IN}$ ,  $I_{OUT} = 1$  mA,  $C_{IN} = C_{OUT} = 0$  µF,  $V_{IN} = 3.5$ V for  $V_R < 2.5$ V and  $V_{IN} = V_R + 1$ V for  $V_R \ge 2.5$ V,  $T_A = +25$ °C

$v_R < 2.5V$ and $v_{IN} = v_R + 1$	$v 101 v_{\rm R} \ge 2.3 v_{\rm r}$	$T_{A} = +25 C$	, 		1	
Parameters	Sym.	Min.	Тур.	Max.	Units	Conditions
Output Voltage Temperature Stability	ΔV <sub>OUT</sub> / (ΔT x V <sub>OUT</sub> )		±50		ppm/°C	$\begin{array}{l} I_{OUT} = 10 \text{ mA} \\ -40^{\circ}\text{C} \leq \text{T}_{\text{A}} \leq +85^{\circ}\text{C} \end{array}$
Current Limit	I <sub>LIMIT</sub>	150	270		mA	$V_{OUT} = 0.95 \text{ x } V_{R}$
Output Short-Circuit Foldback Current	I <sub>OUT_SC</sub>	—	80		mA	V <sub>OUT</sub> = GND
C <sub>OUT</sub> Auto-Discharge Resistance	R <sub>DCHG</sub>	280	450	640	Ω	$\overline{SHDN} = GND$ V <sub>OUT</sub> = V <sub>R</sub>
Noise	e <sub>n</sub>		30		μV(rms)	$C_{IN} = C_{OUT} = 1 \ \mu\text{F}, I_{OUT} = 50$ mA, f = 10 Hz to 100 kHz
Shutdown Input						
SHDN Logic High Input Voltage	V <del>SHDN</del> -HIGH	0.91	—	6.00	V	
SHDN Logic Low Input Voltage	V <del>SHDN</del> -LOW	0	—	0.38	V	
SHDN High-Level Current	ISHDN-HIGH	-0.1	_	+0.1	μA	V <sub>IN</sub> = 6.0V
SHDN Low-Level Current	I <u>SHDN</u> -LOW	-0.1	—	+0.1	μA	$\frac{V_{IN} = 6.0V}{SHDN} = GND$

**Note 1:** The dropout voltage is defined as the input to output differential at which the output voltage drops 2% below the output voltage value that was measured with an applied input voltage of  $V_{IN} = V_R + 1V$ .

2: V<sub>DROP1</sub>, V<sub>DROP2</sub>: Dropout Voltage (Refer to the DC Characteristics Voltage Table).

#### DC CHARACTERISTICS VOLTAGE TABLE

Nominal	Output V	oltage (V)	Dropout Voltage (V)				
Output Voltage	Vo	DUT	V <sub>DROP1</sub>	V <sub>DROP1</sub>	V <sub>DROP2</sub>	V <sub>DROP2</sub>	
V <sub>R</sub> (V)	Min.	Max.	Тур.	Max.	Тур.	Max.	
1.2	1.1800	1.2200	0.87	1.23	1.41	1.93	
1.8	1.7800	1.8200	0.47	0.72	0.99	1.40	
1.9	1.8800	1.9200	0.42	0.64	0.92	1.29	
2.0	1.9800	2.0200	0.37	0.58	0.86	1.20	
2.2	2.1780	2.2220	0.31	0.47	0.75	1.05	
2.5	2.4750	2.5250	0.26	0.40	0.67	0.92	
3.0	2.9700	3.0300	0.17	0.26	0.50	0.67	
3.3	3.2670	3.3330	0.17	0.26	0.50	0.67	
5.0	4.9500	5.0500	0.10	0.16	0.32	0.43	

#### TEMPERATURE SPECIFICATIONS (Note 1)

Parameters		Min.	Тур.	Max.	Units	Conditions
Temperature Ranges						
Operating Ambient Temperature Range	T <sub>A</sub>	-40		+85	°C	
Junction Operating Temperature	Τ <sub>J</sub>	-40		+125	°C	
Storage Temperature Range	T <sub>A</sub>	-55	_	+125	°C	
Package Thermal Resistances						
Thermal Resistance, 1 x 1 UQFN-4Ld	$\theta_{JA}$		181.82	—	°C/W	JEDEC 51-7 FR4 board with thermal vias
	$\theta_{JA}$	_	1000	_	°C/W	Note 2
	$\theta_{JC}$	_	15		°C/W	
Thermal Resistance, SOT-23-5Ld	$\theta_{JA}$	_	166.67	—	°C/W	JEDEC 51-7 FR4 board with thermal vias
	$\theta_{JA}$	_	400	_	°C/W	Note 2
	$\theta_{JC}$	_	81		°C/W	

Note 1: The maximum allowable power dissipation is a function of ambient temperature, the maximum allowable junction temperature, and the thermal resistance from junction to air (i.e., T<sub>A</sub>, T<sub>J</sub>, θ<sub>JA</sub>). Exceeding the maximum allowable power dissipation will cause the device operating junction temperature to exceed the maximum +125°C rating. Sustained junction temperatures above +125°C can impact the device reliability.

2: The device is mounted on one layer PCB with minimal copper that does not provide any additional cooling.

#### 2.0 TYPICAL PERFORMANCE CURVES

**Note:** The graphs and tables provided following this note are a statistical summary based on a limited number of samples and are provided for informational purposes only. The performance characteristics listed herein are not tested or guaranteed. In some graphs or tables, the data presented may be outside the specified operating range (e.g., outside specified power supply range) and therefore outside the warranted range.

**NOTE:** Unless otherwise indicated,  $V_{IN} = 3.5V$  for  $V_R < 2.5V$  or  $V_{IN} = V_R + 1V$  for  $V_R \ge 2.5V$ ,  $I_{OUT} = 1$  mA,  $C_{IN} = C_{OUT} = 0 \ \mu$ F,  $V_{\overline{SHDN}} = V_{IN}$ ,  $T_A = +25^{\circ}$ C.



FIGURE 2-1: Quiescent Current vs. Input Voltage.



FIGURE 2-2: Quiescent Current vs. Input Voltage.



Voltage.





Quiescent Current vs. Input



FIGURE 2-5: Current.

Ground Current vs. Load







**Note:** Unless otherwise indicated,  $V_{IN}$  = 3.5V for  $V_R$  < 2.5V or  $V_{IN}$  =  $V_R$  + 1V for  $V_R \ge 2.5V$ ,  $I_{OUT}$  = 1 mA,  $C_{IN} = C_{OUT} = 0 \ \mu$ F,  $V_{\overline{SHDN}} = V_{IN}$ ,  $T_A$  = +25°C.

Current.



FIGURE 2-8: Ground Current vs. Load Current.



FIGURE 2-9:

Start-Up from V<sub>IN</sub>.



FIGURE 2-10: Start-Up from V<sub>IN</sub>.



FIGURE 2-11: Start-Up from V<sub>IN</sub>.



**FIGURE 2-12:** Start-Up from  $V_{IN}$ .

**Note:** Unless otherwise indicated,  $V_{IN}$  = 3.5V for  $V_R$  < 2.5V or  $V_{IN}$  =  $V_R$  + 1V for  $V_R \ge 2.5V$ ,  $I_{OUT}$  = 1 mA,  $C_{IN} = C_{OUT} = 0 \ \mu$ F,  $V_{\overline{SHDN}} = V_{IN}$ ,  $T_A$  = +25°C.







FIGURE 2-14: Start-Up from V<sub>IN</sub>.











FIGURE 2-17: Start-Up from SHDN.



FIGURE 2-18: Start-Up from SHDN.



Note: Unless otherwise indicated, V<sub>IN</sub> = 3.5V for V<sub>R</sub> < 2.5V or V<sub>IN</sub> = V<sub>R</sub> + 1V for V<sub>R</sub>  $\geq$  2.5V, I<sub>OUT</sub> = 1 mA,  $C_{IN} = C_{OUT} = 0 \ \mu F$ ,  $V_{\overline{SHDN}} = V_{IN}$ ,  $T_A = +25^{\circ}C$ .







FIGURE 2-20:





Current.







FIGURE 2-23: Output Voltage vs. Output Current.



Current.

**Note:** Unless otherwise indicated,  $V_{IN}$  = 3.5V for  $V_R$  < 2.5V or  $V_{IN}$  =  $V_R$  + 1V for  $V_R \ge 2.5V$ ,  $I_{OUT}$  = 1 mA,  $C_{IN} = C_{OUT} = 0 \ \mu$ F,  $V_{\overline{SHDN}} = V_{IN}$ ,  $T_A$  = +25°C.



FIGURE 2-25: Current.



FIGURE 2-26: Output Voltage vs. Output Current.



FIGURE 2-27: Output Voltage vs. Output Current.



Current.

Output Voltage vs. Output



FIGURE 2-29: Output Voltage vs. Input Voltage.



Voltage.

Output Voltage vs. Input



Note: Unless otherwise indicated, V<sub>IN</sub> = 3.5V for V<sub>R</sub> < 2.5V or V<sub>IN</sub> = V<sub>R</sub> + 1V for V<sub>R</sub>  $\geq$  2.5V, I<sub>OUT</sub> = 1 mA,  $C_{IN} = C_{OUT} = 0 \ \mu F$ ,  $V_{\overline{SHDN}} = V_{IN}$ ,  $T_A = +25^{\circ}C$ .





FIGURE 2-32: Output Voltage vs. Input Voltage.



FIGURE 2-33: Temperature.



Temperature.

Output Voltage vs. Ambient



FIGURE 2-35: Output Voltage vs. Ambient Temperature.



FIGURE 2-36: Output Voltage vs. Ambient Temperature.

Note: Unless otherwise indicated, V<sub>IN</sub> = 3.5V for V<sub>R</sub> < 2.5V or V<sub>IN</sub> = V<sub>R</sub> + 1V for V<sub>R</sub>  $\geq$  2.5V, I<sub>OUT</sub> = 1 mA,  $C_{IN} = C_{OUT} = 0 \ \mu\text{F}, \ V_{\overline{SHDN}} = V_{IN}, \ T_A = +25^{\circ}\text{C}.$ 



Dropout Voltage vs. Output FIGURE 2-37: Current.



FIGURE 2-38: Dropout Voltage vs. Output Current.



FIGURE 2-39: Dropout Voltage vs. Output Current.



Current.

Dropout Voltage vs. Output



FIGURE 2-41: Shutdown Threshold Voltage vs. Ambient Temperature.



**FIGURE 2-42:** Dynamic Line Response.







Dynamic Line Response.



FIGURE 2-44:

Dynamic Line Response.



FIGURE 2-45:

Dynamic Line Response.



FIGURE 2-46: Dynamic Line Response.



FIGURE 2-47: Dynamic Line Response.



FIGURE 2-48: D

Dynamic Line Response.

Note: Unless otherwise indicated, V<sub>IN</sub> = 3.5V for V<sub>R</sub> < 2.5V or V<sub>IN</sub> = V<sub>R</sub> + 1V for V<sub>R</sub>  $\geq$  2.5V, I<sub>OUT</sub> = 1 mA,  $C_{IN} = C_{OUT} = 0 \ \mu\text{F}, \ V_{\overline{\text{SHDN}}} = V_{IN}, \ T_A = +25^{\circ}\text{C}.$ 







FIGURE 2-50: Dynamic Load Response.





Dynamic Load Response.







**FIGURE 2-53:** Dynamic Load Response.







Note: Unless otherwise indicated, V<sub>IN</sub> = 3.5V for V<sub>R</sub> < 2.5V or V<sub>IN</sub> = V<sub>R</sub> + 1V for V<sub>R</sub>  $\geq$  2.5V, I<sub>OUT</sub> = 1 mA,  $C_{IN} = C_{OUT} = 0 \ \mu\text{F}, \ V_{\overline{SHDN}} = V_{IN}, \ T_A = +25^{\circ}\text{C}.$ 





FIGURE 2-56:

Dynamic Load Response.



**FIGURE 2-57:** 







FIGURE 2-59: Dynamic Load Response.



Dynamic Load Response.

Dynamic Load Response.

**Note:** Unless otherwise indicated,  $V_{IN}$  = 3.5V for  $V_R$  < 2.5V or  $V_{IN}$  =  $V_R$  + 1V for  $V_R \ge 2.5V$ ,  $I_{OUT}$  = 1 mA,  $C_{IN} = C_{OUT} = 0 \ \mu$ F,  $V_{\overline{SHDN}} = V_{IN}$ ,  $T_A$  = +25°C.







FIGURE 2-62: Dynamic Load Response.





Dynamic Load Response.















Output Noise vs. Frequency.

**Note:** Unless otherwise indicated,  $V_{IN}$  = 3.5V for  $V_R$  < 2.5V or  $V_{IN}$  =  $V_R$  + 1V for  $V_R \ge 2.5V$ ,  $I_{OUT}$  = 1 mA,  $C_{IN} = C_{OUT} = 0 \ \mu$ F,  $V_{\overline{SHDN}} = V_{IN}$ ,  $T_A$  = +25°C.



Rejection vs. Frequency.



FIGURE 2-68: Power Supply Ripple Rejection vs. Frequency.



FIGURE 2-69: Power Supply Ripple Rejection vs. Frequency.



FIGURE 2-70: Power Supply Ripple Rejection vs. Frequency.



FIGURE 2-71: Power Supply Ripple Rejection vs. Frequency.



FIGURE 2-72: Power Supply Ripple Rejection vs. Frequency.

**Note:** Unless otherwise indicated,  $V_{IN}$  = 3.5V for  $V_R$  < 2.5V or  $V_{IN}$  =  $V_R$  + 1V for  $V_R \ge 2.5V$ ,  $I_{OUT}$  = 1 mA,  $C_{IN} = C_{OUT} = 0 \ \mu$ F,  $V_{\overline{SHDN}} = V_{IN}$ ,  $T_A$  = +25°C.



FIGURE 2-73: Power Supply Ripple Rejection vs. Frequency.



FIGURE 2-74: Power Supply Ripple Rejection vs. Frequency.

#### 3.0 PIN DESCRIPTIONS

The descriptions of the pins are listed in Table 3-1.

MCP1711 1X1 UQFN	MCP1711 SOT-23	Symbol	Description
4	1	V <sub>IN</sub>	Unregulated Input Supply Voltage
2	2	GND	Ground Terminal
3	3	SHDN	Shutdown Input
—	4	NC	Not Connected (SOT-23 only)
1	5	V <sub>OUT</sub>	Regulated Voltage Output
5	_	EP	Exposed Thermal Pad (1x1 UQFN only)

#### TABLE 3-1: PIN FUNCTION TABLE

#### 3.1 Unregulated Input Voltage (V<sub>IN</sub>)

Connect the V<sub>IN</sub> pin to the output of the unregulated source voltage. Like all low dropout linear regulators, low-source impedance is necessary for ensuring stable operation of the LDO. The amount of capacitance required to ensure low-source impedance will depend on the proximity of the input source capacitors or battery type. For most applications, 0.1  $\mu$ F of capacitance will ensure stable operation of the LDO circuit. If the output capacitor is used, the input capacitor should have a capacitance value equal to or greater than the output capacitor for performance applications.

The input capacitor will supply the load current during transients and improve performance. For applications that have low load currents, the input capacitance requirement can be lowered.

The type of capacitor used may be ceramic, tantalum or aluminum electrolytic. The low ESR characteristics of the ceramic will yield better noise and Power Supply Rejection Ratio (PSRR) performance at high frequency.

#### 3.2 Ground Terminal (GND)

This is the regulator ground. Tie GND to the negative side of the output capacitor (if used) and to the negative side of the input capacitor. Only the LDO bias current flows out of this pin, so there is no high current. The LDO output regulation is referenced to this pin. Minimize voltage drops between this pin and the negative side of the load. If a PCB ground plane is not used, minimize the length of the trace between the GND pin and the ground line.

#### 3.3 Shutdown Input (SHDN)

The SHDN input is used to turn the LDO output voltage on and off.

When the SHDN input is at logic High level, the LDO output voltage is enabled. When the SHDN pin is pulled to a logic Low level, the LDO output voltage is disabled. When the SHDN pin is pulled low, the  $V_{OUT}$  pin is pulled down to the ground level via, parallel to the feedback resistors (R<sub>1</sub> and R<sub>2</sub>), and the C<sub>OUT</sub> discharge resistance (R<sub>DCHG</sub>).

The output voltage becomes unstable when the  $\overline{\text{SHDN}}$  pin is left floating.

#### 3.4 Not Connected Pin (NC)

The SOT-23 package has a pin that is not connected. This pin should be either left floating or tied to the ground plane.

#### 3.5 Regulated Output Voltage (V<sub>OUT</sub>)

Connect the  $V_{OUT}$  pin to the positive side of the load and to the positive side of the output capacitor (if used). The positive side of the output capacitor should be physically located as close as possible to the LDO  $V_{OUT}$  pin. The current flowing out of this pin is equal to the DC load current.

#### 3.6 Exposed Thermal Pad (EP)

The 4-lead 1 x 1 UQFN package has an exposed metal pad on the bottom of the package. The exposed metal pad gives the device better thermal characteristics by providing a good thermal path to either a PCB isolated plane or a PCB ground plane. The exposed pad of the package is not internally connected to GND.

#### 4.0 DEVICE OVERVIEW

The MCP1711 device is a 150 mA output current, low-dropout (LDO) voltage regulator. The low dropout voltage at high current makes it ideal for battery-powered applications. The input voltage ranges from 1.4V to 6.0V. Unlike other high output current LDOs, the MCP1711 typically draws only 600 nA quiescent current and maximum 45  $\mu$ A ground current at 150 mA load. MCP1711 has a shutdown control input pin (SHDN). The output voltage options are fixed.

#### 4.1 LDO Output Voltage

The MCP1711 LDO has a fixed output voltage. The output voltage range is 1.2V to 5.0V.

#### 4.2 Output Current and Current Limiting

The MCP1711 is tested and ensured to supply a maximum of 150 mA of output current. The device can provide a highly accurate output voltage even if the output current is only 1  $\mu$ A (very light load).

The MCP1711 also features a true output current foldback. If an excessive load, due to a low impedance short-circuit condition at the output load, is detected, the output current and voltage will fold back towards 80 mA and 0V, respectively. The output voltage and current will resume normal levels when the excessive load is removed. If the overload condition is a soft overload, the MCP1711 will supply higher load currents of up to 270 mA typical. This allows for device usage in applications that have pulsed load currents having an average output current value of 150 mA or less.

#### 4.3 Output Capacitor

The MCP1711 can provide a stable output voltage even without an additional output capacitor due to its excellent internal phase compensation, so that a minimum output capacitance is not required. In order to improve the load step response and PSRR, an output capacitor can be added. A value in the range of 0.1  $\mu$ F to 1.0  $\mu$ F is recommended for most applications. The capacitor should be placed as close as possible to the V<sub>OUT</sub> pin and the GND pin. The device is compatible with low ESR ceramic capacitors. Ceramic materials like X7R and X5R have low temperature coefficients and are well within the acceptable ESR range required. A typical 1  $\mu$ F X7R 0805 capacitor has an ESR of 50 mΩ.

#### 4.4 Input Capacitor

Low-input source impedance is necessary for the LDO output to operate properly. When operating from batteries, or in applications with long lead length (> 10 inches) between the input source and the LDO, some input capacitance is recommended. A minimum of 0.1 µF to 1.0 µF is recommended for most applications. For applications that have output step load requirements, the input capacitance of the LDO is very important. The input capacitance provides the LDO with a good local low-impedance source to pull the transient current from, so it responds quickly to the output load step. For good step response performance, the input capacitor should be of an equivalent or higher value than the output capacitor. The capacitor should be placed as close to the input of the LDO as is practical. Larger input capacitors will also help reduce any high-frequency noise on the input and output of the LDO as well as reduce the effects of any inductance that exists between the input source voltage and the input capacitance of the LDO.

#### 4.5 Shutdown Input (SHDN)

The MCP1711 internal circuitry can be shut down via the signal from the SHDN pin. The SHDN input is an active-low input signal that turns the LDO on and off. The shutdown threshold is a fixed voltage level. The minimum value of this shutdown threshold required to turn the output on is 0.91V. The maximum value required to turn the output off is 0.38V.

In Shutdown mode, the V<sub>OUT</sub> pin will be pulled down to the ground level via, parallel to feedback resistors and C<sub>OUT</sub> discharge resistance R<sub>DCHG</sub>. In this state, the application is protected from a glitch operation caused by the electric charge at the output capacitor. Moreover, the discharge time of the output capacitor is set by the C<sub>OUT</sub> auto-discharge resistance (R<sub>DCHG</sub>) and the output capacitor C<sub>OUT</sub>. By setting the time constant of a C<sub>OUT</sub> auto-discharge resistance value (R<sub>DCHG</sub>) and the output capacitor value (C<sub>OUT</sub>) as  $\tau = C_{OUT} \times R_{DCHG}$ the output voltage after discharge via the internal switch is calculated using Equation 4-1:

Note: The  $R_{DCHG}$  depends on  $V_{IN}$ ; when  $V_{IN}$  is high the  $R_{DCHG}$  is low.

#### EQUATION 4-1:

$$V_{OUT}(t) = V_{OUT} \times e^{(-t/\tau)}$$
  
or  
$$t = \tau \times ln(V_{OUT}/V_{OUT}(t))$$

Where:

 $V_{OUT}(t) =$  The output voltage during discharging  $V_{OUT} =$  The initial output voltage t = Discharge time  $\tau = C_{OUT} \times R_{DCHG}$ 

#### 4.6 Dropout Voltage

Dropout Voltage is defined as the input-to-output voltage differential at which the output voltage drops 2% below the nominal value that was measured with a  $V_R + 1.0V$  differential applied. See Section 1.0 "Electrical Characteristics", for minimum and maximum voltage specifications.

#### 5.0 APPLICATION CIRCUITS AND ISSUES

#### 5.1 Typical Application

The MCP1711 is most commonly used as a voltage regulator. Its low quiescent current and low dropout voltage make it ideal for a multitude of battery-powered applications.



#### 5.2 Power Calculations

#### 5.2.1 POWER DISSIPATION

The internal power dissipation of the MCP1711 is a function of input voltage, output voltage and output current. The power dissipation, as a result of the quiescent current draw, is so low that it is insignificant (0.6  $\mu$ A x V<sub>IN</sub>). To calculate the internal power dissipation of the LDO use Equation 5-1:

#### EQUATION 5-1:

$$P_{LDO} = (V_{IN(MAX)} - V_{OUT(MIN)}) \times I_{OUT(MAX)}$$

Where:

P <sub>LDO</sub>	=	LDO pass device internal power
		dissipation

V <sub>IN(MAX)</sub>	=	Maximum input voltage
V <sub>OUT(MIN)</sub>	=	LDO minimum output voltage,
( )		including the line and load
		regulations

The maximum continuous operating junction temperature specified for the MCP1711 is +125°C. To estimate the internal junction temperature of the MCP1711, the total internal power dissipation is multiplied by the thermal resistance from junction-to-ambient ( $R\theta_{IA}$ ).

The thermal resistance from junction-to-ambient for the 5-Lead SOT-23 package is estimated at:

- 166.67°C with JEDEC 51-7 FR-4 board with thermal vias and
- 400 °C/W when the device is not mounted on the PCB, or is mounted on the one layer PCB with minimal copper that doesn't provide any additional cooling.

#### **EQUATION 5-2:**

$$T_{J(MAX)} = P_{TOTAL} \times R \theta_{JA} + T_{A(MAX)}$$

Where:

T <sub>J(MAX)</sub> =	Maximum continuous junction temperature
P <sub>TOTAL</sub> =	Total device power dissipation
$R\theta_{JA} =$	Thermal resistance from junction to ambient
T <sub>A(MAX)</sub> =	Maximum ambient temperature

The maximum power dissipation capability for a package can be calculated if given the junction-to-ambient thermal resistance ( $R\theta_{JA}$ ) and the maximum ambient temperature for the application. Equations 5-3 to 5-5 can be used to determine the package maximum internal power dissipation:

#### **EQUATION 5-3:**

$$P_{D(MAX)} = \frac{(T_{J(MAX)} - T_{A(MAX)})}{R \theta_{JA}}$$

Where:

- $P_{D(MAX)}$  = Maximum device power dissipation
- T<sub>J(MAX)</sub> = Maximum continuous junction temperature

 $T_{A(MAX)}$  = Maximum ambient temperature

 $R\theta_{JA}$  = Thermal resistance from junction to ambient

#### **EQUATION 5-4:**

$$T_{J(RISE)} = P_{D(MAX)} \times R \theta_{JA}$$

Where:

- $T_{J(RISE)}$  = Rise in device junction temperature over the ambient temperature
- P<sub>D(MAX)</sub> = Maximum device power dissipation
  Rθ<sub>JA</sub> = Thermal resistance from junction to ambient

#### **EQUATION 5-5:**

$$T_J = T_{J(RISE)} + T_A$$

Where:

 $T_J$  = Junction temperature

$$T_{J(RISE)}$$
 = Rise in device junction temperature over the ambient temperature

 $T_A$  = Ambient temperature

#### 5.3 Voltage Regulator

Internal power dissipation, junction temperature rise, junction temperature and maximum power dissipation are calculated in the following example. The power dissipation, as a result of ground current, is small enough to be neglected.

#### 5.3.1 POWER DISSIPATION EXAMPLE

#### EXAMPLE 5-1: POWER DISSIPATION

Package

Package Type = SOT-23

Input Voltage

 $V_{IN} = 3.5V \text{ to } 4.8V$ 

#### LDO Output Voltages and Currents

$$V_{OUT} = 1.8V$$

 $I_{OUT} = 50 \text{ mA}$ 

Maximum Ambient Temperature

 $T_{A(MAX)} = +40^{\circ}C$ 

#### **Internal Power Dissipation**

Internal Power dissipation is the product of the LDO output current times the voltage across the LDO (V\_{IN} to V\_{OUT}).

$$P_{LDO(MAX)} = (V_{IN(MAX)} - V_{OUT(MIN)}) x$$
$$I_{OUT(MAX)}$$

V<sub>OUT(MIN)</sub> = 1.78V - 0.05V = 1.73V, where 1.78V is the minimum output voltage due to accuracy, and 0.05V is the load regulation; due to very small input voltage range, the line regulation is neglected

 $P_{LDO} = (4.8V - 1.73V) \times 50 \text{ mA}$ 

$$P_{LDO} = 153.5 \text{ mW}$$

#### 5.3.1.1 Device Junction Temperature Rise

The internal junction temperature rise is a function of internal power dissipation and the thermal resistance from junction to ambient for the application. The thermal resistance from junction to ambient ( $R\theta_{JA}$ ) is derived from an EIA/JEDEC standard for measuring thermal resistance for small surface mount packages.

The EIA/JEDEC specification is JESD51-7, *High Effective Thermal Conductivity Test Board for Leaded Surface Mount Packages.* The standard describes the test method and board specifications for measuring the thermal resistance from junction to ambient. The actual thermal resistance for a particular application can vary depending on many factors, such as copper area and thickness. Refer to AN792 – A Method to Determine *How Much Power a SOT-23 Can Dissipate in an Application* (DS00792), for more information regarding this subject.

#### EXAMPLE 5-2:

$$T_{J(RISE)} = P_{TOTAL} x R\theta_{JA}$$
  
 $T_{JRISE} = 153.5 \text{ mW } x 400.0^{\circ}\text{C/W}$ 

 $T_{\text{JRISE}} = 61.4^{\circ}\text{C}$ 

#### 5.3.1.2 Junction Temperature Estimate

To estimate the internal junction temperature, the calculated temperature rise is added to the ambient or offset temperature. For this example, the worst-case junction temperature is estimated:

#### EXAMPLE 5-3:

$$T_{J} = T_{JRISE} + T_{A(MAX)}$$
$$T_{J} = 61.4^{\circ}C + 40^{\circ}C = 101.4^{\circ}C$$

5.3.1.3 Maximum Package Power Dissipation Example at +40°C Ambient Temperature

#### EXAMPLE 5-4:

SOT-23 (400.0 °C/W = R<sub>0JA</sub>)

$$P_{D(MAX)} = (125^{\circ}C - 40^{\circ}C)/400^{\circ}C/W$$

 $P_{D(MAX)} = 212 \text{ mW}$ 

#### 5.4 Voltage Reference

The MCP1711 can be used not only as a regulator, but also as a low quiescent current voltage reference. In many microcontroller applications, the initial accuracy of the reference can be calibrated using production test equipment or by using a ratio measurement. When the initial accuracy is calibrated, the thermal stability and line regulation tolerance are the only errors introduced by the MCP1711 LDO. The low cost, low quiescent current and small ceramic output capacitor are all advantages when using the MCP1711 as a voltage reference.



FIGURE 5-2: Using the MCP1711 as a Voltage Reference.

#### 5.5 Pulsed Load Applications

For some applications, there are pulsed load current events that may exceed the specified 150 mA maximum specification of the MCP1711. The internal current limit of the MCP1711 will prevent high peak-load demands from causing nonrecoverable damage. The 150 mA rating is a maximum average continuous rating. As long as the average current does not exceed 150 mA, higher pulsed load currents can be applied to the MCP1711. The typical current limit for the MCP1711 is 270 mA ( $T_A = +25^{\circ}$ C).

#### 6.0 PACKAGING INFORMATION

#### 6.1 Package Marking Information

4-Lead UQFN (1x1x0.6 mm)



Device	Code
MCP1711T-12I/5X	P2NN
MCP1711T-18I/5X	P8NN
MCP1711T-20I/5X	PANN
MCP1711T-22I/5X	PCNN
MCP1711T-25I/5X	PFNN
MCP1711T-30I/5X	PNNN
MCP1711T-33I/5X	PSNN

Example



5-Lead SOT-23



Device	Code
MCP1711T-12I/OT	9A2xx
MCP1711T-18I/OT	9A8xx
MCP1711T-19I/OT	9A9xx
MCP1711T-22I/OT	9ACxx
MCP1711T-25I/OT	9AFxx
MCP1711T-30I/OT	9ANxx
MCP1711T-33I/OT	9ASxx
MCP1711T-50I/OT	9BAxx

Example



Legend	I: XXX Y YY WW NNN @3 *	Customer-specific information Year code (last digit of calendar year) Year code (last 2 digits of calendar year) Week code (week of January 1 is week '01') Alphanumeric traceability code Pb-free JEDEC designator for Matte Tin (Sn) This package is Pb-free. The Pb-free JEDEC designator (@3) can be found on the outer packaging for this package.
Note:	be carrie	nt the full Microchip part number cannot be marked on one line, it will d over to the next line, thus limiting the number of available s for customer-specific information.

## 4-Lead Plastic Ultra Thin Quad Flatpack No-Leads (5X) - 1x1x0.6mm [UQFN] (Formerly USPQ-4B04)

**Note:** For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



Microchip Technology Drawing C04-393B Sheet 1 of 2

### 4-Lead Plastic Ultra Thin Quad Flatpack No-Leads (5X) - 1x1x0.6mm [UQFN] (Formerly USPQ-4B04)

**Note:** For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	Units		MILLIMETERS			
Dimension Limits		MIN	NOM	MAX		
Number of Terminals	Ν		4			
Pitch	е	0.65 BSC				
Overall Height	Α	0.60				
Overall Width	E	1.00 BSC				
Exposed Pad Width	E2	0.43	0.43 0.48 0.			
Overall Length	D	1.00 BSC				
Exposed Pad Length	D2	0.43	0.53			
Terminal Width	b	0.20	0.25	0.30		
Terminal Length	L1	0.20	0.25	0.30		
Terminal Length	L2	0.27	0.32	0.37		
-	L3	0.02	0.07	0.12		
Terminal Chamfer	СН	-	0.18	-		

Notes:

- 1. Pin 1 visual index feature may vary, but must be located within the hatched area.
- 2. Package is saw singulated
- 3. Dimensioning and tolerancing per ASME Y14.5M
  - BSC: Basic Dimension. Theoretically exact value shown without tolerances.

REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing C04-393B Sheet 2 of 2

### 4-Lead Plastic Ultra Thin Quad Flatpack No-Leads (5X) - 1x1x0.6mm [UQFN] (Formerly USPQ-4B04)

**Note:** For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



#### RECOMMENDED LAND PATTERN

Units	MILLIMETERS			
Dimension Limits	MIN	NOM	MAX	
E	0.65 BSC			
X1		0.25		
X2		0.18		
X4		0.48		
Y1		0.40		
Y2		0.47		
Y3		0.22		
Y4		0.48		

Notes:

1. Dimensioning and tolerancing per ASME Y14.5M

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing C04-2393B

#### 5-Lead Plastic Small Outline Transistor (OT) [SOT-23]

**Note:** For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging









	Units	MILLIMETERS			
	MIN	NOM	MAX		
Number of Pins	N	5			
Lead Pitch	е		0.95 BSC		
Outside Lead Pitch	e1	1.90 BSC			
Overall Height	A	0.90 – 1.4			
Molded Package Thickness	A2	0.89	-	1.30	
Standoff	A1	0.00	-	0.15	
Overall Width	E	2.20	-	3.20	
Molded Package Width	E1	1.30	1.30 – 1.8		
Overall Length	D	2.70	-	3.10	
Foot Length	L	0.10	-	0.60	
Footprint	L1	0.35	-	0.80	
Foot Angle	φ	0°	-	30°	
Lead Thickness	С	0.08 – 0.26			
Lead Width	b	0.20	_	0.51	

#### Notes:

1. Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.127 mm per side.

2. Dimensioning and tolerancing per ASME Y14.5M.

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing C04-091B

#### 5-Lead Plastic Small Outline Transistor (OT) [SOT-23]

**Note:** For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	Units			MILLIMETERS			
Dimension	Dimension Limits		NOM	MAX			
Contact Pitch	E	0.95 BSC					
Contact Pad Spacing	С		2.80				
Contact Pad Width (X5)	X	0.6					
Contact Pad Length (X5)	Y	1.1					
Distance Between Pads	G	1.70					
Distance Between Pads	GX	0.35					
Overall Width	Z			3.90			

Notes:

1. Dimensioning and tolerancing per ASME Y14.5M

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing No. C04-2091A

#### APPENDIX A: REVISION HISTORY

#### **Revision D (October 2016)**

The following is the list of modifications:

- Added the 2.0V output voltage option (for the UQFN package) and related information throughout the document
- Minor typographical corrections.

#### **Revision C (March 2016)**

• Minor typographical corrections.

#### **Revision B (October 2015)**

The following is the list of modifications:

- Updated thermal resistances in Section 1.0, Electrical Characteristics.
- Updated Section 2.0, Typical Performance Curves with new load step screen-shots.

#### **Revision A (June 2015)**

• Original release of this document.

NOTES:

#### **PRODUCT IDENTIFICATION SYSTEM**

To order or obtain information, e.g., on pricing or delivery, contact your local Microchip representative or sales office.

PART NO. [X] <sup>(1)</sup> - <u>X X /XX</u>		Examples:					
Device Tape a			t Temperature		a)	MCP1711T-12I/OT:	Tape and Reel, 1.2V Output Voltage, Industrial temperature, 5LD SOT-23
Device:	MCP17		0 mA Ultra-Low Quies apacitorless LDO Reg		b)	MCP1711T-18I/OT:	Tape and Reel, 1.8V Output Voltage, Industrial temperature, 5LD SOT-23
Output Voltage:	12 18 19 20 22	= 1.2V = 1.8V = 1.9V = 2.0V = 2.2V			c)	MCP1711T-19I/OT:	Tape and Reel, 1.9V Output Voltage, Industrial temperature, 5LD SOT-23
	25 30 33 50	= 2.5V = 3.0V = 3.3V = 5.0V			d)	MCP1711T-22I/OT:	Tape and Reel, 2.2V Output Voltage, Industrial temperature, 5LD SOT-23
Temperature Range:	I	= -40°	C to +85°C (Industrial)	)	e)	MCP1711T-25I/OT:	Tape and Reel, 2.5V Output Voltage, Industrial temperature, 5LD SOT-23
Packages:	OT 5X	= Plas	tic Small Outline Tran tic Ultra Thin Quad Fla ad 1x1 UQFN	sistor, 5-Lead SOT-23 atpack No-Leads,	f)	MCP1711T-30I/OT:	Tape and Reel, 3.0V Output Voltage, Industrial temperature, 5LD SOT-23
					g)	MCP1711T-33I/OT:	Tape and Reel, 3.3V Output Voltage, Industrial temperature, 5LD SOT-23
					h)	MCP1711T-50I/OT:	Tape and Reel, 5.0V Output Voltage, Industrial temperature, 5LD SOT-23
					a)	MCP1711T-12I/5X:	Tape and Reel, 1.2V Output Voltage, Industrial temperature, 4LD UQFN
					b)	MCP1711T-18I/5X:	Tape and Reel, 1.8V Output Voltage, Industrial temperature, 4LD UQFN
					c)	MCP1711T-20I/5X:	Tape and Reel, 2.0V Output Voltage, Industrial temperature, 4LD UQFN
					d)	MCP1711T-22I/5X:	Tape and Reel, 2.2V Output Voltage, Industrial temperature, 4LD UQFN
					e)	MCP1711T-25I/5X:	Tape and Reel, 2.5V Output Voltage, Industrial temperature, 4LD UQFN
					f)	MCP1711T-30I/5X:	Tape and Reel, 3.0V Output Voltage, Industrial temperature, 4LD UQFN
					Not	catalog part num used for ordering the device packa	identifier only appears in th ber description. This identifier purposes and is not printed o age. Check with your Microchi package availability with th otion.

NOTES:

#### Note the following details of the code protection feature on Microchip devices:

- Microchip products meet the specification contained in their particular Microchip Data Sheet.
- Microchip believes that its family of products is one of the most secure families of its kind on the market today, when used in the intended manner and under normal conditions.
- There are dishonest and possibly illegal methods used to breach the code protection feature. All of these methods, to our knowledge, require using the Microchip products in a manner outside the operating specifications contained in Microchip's Data Sheets. Most likely, the person doing so is engaged in theft of intellectual property.
- Microchip is willing to work with the customer who is concerned about the integrity of their code.
- Neither Microchip nor any other semiconductor manufacturer can guarantee the security of their code. Code protection does not mean that we are guaranteeing the product as "unbreakable."

Code protection is constantly evolving. We at Microchip are committed to continuously improving the code protection features of our products. Attempts to break Microchip's code protection feature may be a violation of the Digital Millennium Copyright Act. If such acts allow unauthorized access to your software or other copyrighted work, you may have a right to sue for relief under that Act.

Information contained in this publication regarding device applications and the like is provided only for your convenience and may be superseded by updates. It is your responsibility to ensure that your application meets with your specifications. MICROCHIP MAKES NO REPRESENTATIONS OR WARRANTIES OF ANY KIND WHETHER EXPRESS OR IMPLIED, WRITTEN OR ORAL, STATUTORY OR OTHERWISE, RELATED TO THE INFORMATION, INCLUDING BUT NOT LIMITED TO ITS CONDITION, QUALITY, PERFORMANCE, MERCHANTABILITY OR FITNESS FOR PURPOSE. Microchip disclaims all liability arising from this information and its use. Use of Microchip devices in life support and/or safety applications is entirely at the buyer's risk, and the buyer agrees to defend, indemnify and hold harmless Microchip from any and all damages, claims, suits, or expenses resulting from such use. No licenses are conveyed, implicitly or otherwise, under any Microchip intellectual property rights unless otherwise stated.

Microchip received ISO/TS-16949:2009 certification for its worldwide headquarters, design and wafer fabrication facilities in Chandler and Tempe, Arizona; Gresham, Oregon and design centers in California and India. The Company's quality system processes and procedures are for its PIC® MCUs and dsPIC® DSCs, KEELoQ® code hopping devices, Serial EEPROMs, microperipherals, nonvolatile memory and analog products. In addition, Microchip's quality system for the design and manufacture of development systems is ISO 9001:2000 certified.

### QUALITY MANAGEMENT SYSTEM CERTIFIED BY DNV = ISO/TS 16949=

#### Trademarks

The Microchip name and logo, the Microchip logo, AnyRate, dsPIC, FlashFlex, flexPWR, Heldo, JukeBlox, KeeLoq, KeeLoq logo, Kleer, LANCheck, LINK MD, MediaLB, MOST, MOST logo, MPLAB, OptoLyzer, PIC, PICSTART, PIC32 logo, RightTouch, SpyNIC, SST, SST Logo, SuperFlash and UNI/O are registered trademarks of Microchip Technology Incorporated in the U.S.A. and other countries.

ClockWorks, The Embedded Control Solutions Company, ETHERSYNCH, Hyper Speed Control, HyperLight Load, IntelliMOS, mTouch, Precision Edge, and QUIET-WIRE are registered trademarks of Microchip Technology Incorporated in the U.S.A.

Analog-for-the-Digital Age, Any Capacitor, AnyIn, AnyOut, BodyCom, chipKIT, chipKIT logo, CodeGuard, dsPICDEM, dsPICDEM.net, Dynamic Average Matching, DAM, ECAN, EtherGREEN, In-Circuit Serial Programming, ICSP, Inter-Chip Connectivity, JitterBlocker, KleerNet, KleerNet logo, MiWi, motorBench, MPASM, MPF, MPLAB Certified logo, MPLIB, MPLINK, MultiTRAK, NetDetach, Omniscient Code Generation, PICDEM, PICDEM.net, PICkit, PICtail, PureSilicon, RightTouch logo, REAL ICE, Ripple Blocker, Serial Quad I/O, SQI, SuperSwitcher, SuperSwitcher II, Total Endurance, TSHARC, USBCheck, VariSense, ViewSpan, WiperLock, Wireless DNA, and ZENA are trademarks of Microchip Technology Incorporated in the U.S.A. and other countries.

SQTP is a service mark of Microchip Technology Incorporated in the U.S.A.

Silicon Storage Technology is a registered trademark of Microchip Technology Inc. in other countries.

GestIC is a registered trademarks of Microchip Technology Germany II GmbH & Co. KG, a subsidiary of Microchip Technology Inc., in other countries.

All other trademarks mentioned herein are property of their respective companies.

© 2015-2016, Microchip Technology Incorporated, Printed in the U.S.A., All Rights Reserved.

ISBN: 978-1-5224-1009-6



### **Worldwide Sales and Service**

#### AMERICAS

Corporate Office 2355 West Chandler Blvd. Chandler, AZ 85224-6199 Tel: 480-792-7200 Fax: 480-792-7277 Technical Support: http://www.microchip.com/ support

Web Address: www.microchip.com

Atlanta Duluth, GA Tel: 678-957-9614 Fax: 678-957-1455

Austin, TX Tel: 512-257-3370

Boston Westborough, MA Tel: 774-760-0087 Fax: 774-760-0088

**Chicago** Itasca, IL Tel: 630-285-0071 Fax: 630-285-0075

**Cleveland** Independence, OH Tel: 216-447-0464 Fax: 216-447-0643

**Dallas** Addison, TX Tel: 972-818-7423 Fax: 972-818-2924

Detroit Novi, MI Tel: 248-848-4000

Houston, TX Tel: 281-894-5983

Indianapolis Noblesville, IN Tel: 317-773-8323 Fax: 317-773-5453

Los Angeles Mission Viejo, CA Tel: 949-462-9523 Fax: 949-462-9608

New York, NY Tel: 631-435-6000

San Jose, CA Tel: 408-735-9110

**Canada - Toronto** Tel: 905-695-1980 Fax: 905-695-2078

#### ASIA/PACIFIC

Asia Pacific Office Suites 3707-14, 37th Floor Tower 6, The Gateway

Harbour City, Kowloon Hong Kong Tel: 852-2943-5100 Fax: 852-2401-3431

Australia - Sydney Tel: 61-2-9868-6733 Fax: 61-2-9868-6755

**China - Beijing** Tel: 86-10-8569-7000 Fax: 86-10-8528-2104

**China - Chengdu** Tel: 86-28-8665-5511 Fax: 86-28-8665-7889

China - Chongqing Tel: 86-23-8980-9588 Fax: 86-23-8980-9500

China - Dongguan Tel: 86-769-8702-9880

China - Guangzhou Tel: 86-20-8755-8029

**China - Hangzhou** Tel: 86-571-8792-8115 Fax: 86-571-8792-8116

China - Hong Kong SAR Tel: 852-2943-5100

**China - Nanjing** Tel: 86-25-8473-2460 Fax: 86-25-8473-2470

Fax: 852-2401-3431

**China - Qingdao** Tel: 86-532-8502-7355 Fax: 86-532-8502-7205

**China - Shanghai** Tel: 86-21-5407-5533 Fax: 86-21-5407-5066

China - Shenyang Tel: 86-24-2334-2829 Fax: 86-24-2334-2393

**China - Shenzhen** Tel: 86-755-8864-2200 Fax: 86-755-8203-1760

**China - Wuhan** Tel: 86-27-5980-5300 Fax: 86-27-5980-5118

**China - Xian** Tel: 86-29-8833-7252 Fax: 86-29-8833-7256 ASIA/PACIFIC

**China - Xiamen** Tel: 86-592-2388138 Fax: 86-592-2388130

China - Zhuhai Tel: 86-756-3210040 Fax: 86-756-3210049

India - Bangalore Tel: 91-80-3090-4444 Fax: 91-80-3090-4123

India - New Delhi Tel: 91-11-4160-8631 Fax: 91-11-4160-8632

India - Pune Tel: 91-20-3019-1500

**Japan - Osaka** Tel: 81-6-6152-7160 Fax: 81-6-6152-9310

**Japan - Tokyo** Tel: 81-3-6880- 3770 Fax: 81-3-6880-3771

**Korea - Daegu** Tel: 82-53-744-4301 Fax: 82-53-744-4302

Korea - Seoul Tel: 82-2-554-7200 Fax: 82-2-558-5932 or 82-2-558-5934

Malaysia - Kuala Lumpur Tel: 60-3-6201-9857 Fax: 60-3-6201-9859

Malaysia - Penang Tel: 60-4-227-8870 Fax: 60-4-227-4068

Philippines - Manila Tel: 63-2-634-9065 Fax: 63-2-634-9069

**Singapore** Tel: 65-6334-8870 Fax: 65-6334-8850

**Taiwan - Hsin Chu** Tel: 886-3-5778-366 Fax: 886-3-5770-955

**Taiwan - Kaohsiung** Tel: 886-7-213-7828

Taiwan - Taipei Tel: 886-2-2508-8600

Fax: 886-2-2508-0102 Thailand - Bangkok Tel: 66-2-694-1351

Fax: 66-2-694-1350

#### EUROPE

Austria - Wels Tel: 43-7242-2244-39 Fax: 43-7242-2244-393

**Denmark - Copenhagen** Tel: 45-4450-2828 Fax: 45-4485-2829

France - Paris Tel: 33-1-69-53-63-20 Fax: 33-1-69-30-90-79

Germany - Dusseldorf Tel: 49-2129-3766400

Germany - Karlsruhe Tel: 49-721-625370

**Germany - Munich** Tel: 49-89-627-144-0 Fax: 49-89-627-144-44

Italy - Milan Tel: 39-0331-742611 Fax: 39-0331-466781

Italy - Venice Tel: 39-049-7625286

**Netherlands - Drunen** Tel: 31-416-690399 Fax: 31-416-690340

Poland - Warsaw Tel: 48-22-3325737

**Spain - Madrid** Tel: 34-91-708-08-90 Fax: 34-91-708-08-91

Sweden - Stockholm Tel: 46-8-5090-4654

**UK - Wokingham** Tel: 44-118-921-5800 Fax: 44-118-921-5820

06/23/16